

Automotive MOSFET

OptiMOS™ 7 Power-Transistor



Features

- OptiMOS™ power MOSFET for automotive applications
- N-channel – Enhancement mode – Normal Level
- Extended qualification beyond AEC-Q101
- Enhanced electrical testing
- Robust design
- MSL1 up to 260°C peak reflow
- 175°C operating temperature
- RoHS compliant
- 100% Avalanche tested

Potential Applications

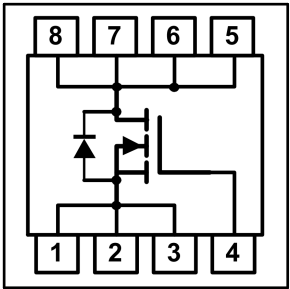
General automotive applications.

Product Validation

Qualified for automotive applications. Product validation according to AEC-Q101.

Product Summary

|                      |      |    |
|----------------------|------|----|
| $V_{DS}$             | 40   | V  |
| $R_{DS(on)}$         | 3.25 | mΩ |
| $I_D$ (chip limited) | 97   | A  |



| Type          | Package        | Marking |
|---------------|----------------|---------|
| IAUZN04S7N032 | PG-TSDSON-8-44 | 4J      |

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## Maximum Ratings

at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter                                    | Symbol        | Conditions                                                                              | Value        | Unit             |
|----------------------------------------------|---------------|-----------------------------------------------------------------------------------------|--------------|------------------|
| Continuous drain current                     | $I_D$         | $V_{GS} = 10\text{ V}$ , Chip limitation <sup>1,2)</sup>                                | 97           | A                |
|                                              |               | $V_{GS} = 10\text{ V}$ , DC current                                                     | 60           |                  |
|                                              |               | $T_a = 100^\circ\text{C}$ , $V_{GS} = 10\text{ V}$ , $R_{thJA}$ on 2s2p <sup>2,3)</sup> | 17           |                  |
| Pulsed drain current <sup>2)</sup>           | $I_{D,pulse}$ | $T_C = 25^\circ\text{C}$ , $t_p = 100\text{ }\mu\text{s}$                               | 235          |                  |
| Avalanche energy, single pulse <sup>2)</sup> | $E_{AS}$      | $I_D = 24\text{ A}$                                                                     | 40           | mJ               |
| Avalanche current, single pulse              | $I_{AS}$      | –                                                                                       | 47           | A                |
| Gate source voltage                          | $V_{GS}$      | –                                                                                       | $\pm 20$     | V                |
| Power dissipation                            | $P_{tot}$     | $T_C = 25^\circ\text{C}$                                                                | 58           | W                |
| Operating temperature                        | $T_j$         | –                                                                                       | -55 ... +175 | $^\circ\text{C}$ |

## Thermal Characteristics<sup>2)</sup>

| Parameter                                            | Symbol     | Conditions | Values |      |      | Unit |
|------------------------------------------------------|------------|------------|--------|------|------|------|
|                                                      |            |            | min.   | typ. | max. |      |
| Thermal resistance, junction - case                  | $R_{thJC}$ | –          | –      | –    | 2.6  | K/W  |
| Thermal resistance, junction - ambient <sup>3)</sup> | $R_{thJA}$ | –          | –      | 41   | –    |      |

## Electrical Characteristics

 at  $T_j = 25^\circ\text{C}$ , unless otherwise specified

| Parameter | Symbol | Conditions | Values |      |      | Unit |
|-----------|--------|------------|--------|------|------|------|
|           |        |            | min.   | typ. | max. |      |

### Static Characteristics

|                                  |               |                                                                                    |     |      |      |               |
|----------------------------------|---------------|------------------------------------------------------------------------------------|-----|------|------|---------------|
| Drain-source breakdown voltage   | $V_{(Br)DSS}$ | $V_{GS} = 0\text{ V}$ ,<br>$I_D = 1\text{ mA}$                                     | 40  | –    | –    | V             |
| Gate threshold voltage           | $V_{GS(th)}$  | $V_{DS} = V_{GS}$ , $I_D = 15\text{ }\mu\text{A}$                                  | 2.2 | 2.6  | 3.0  |               |
| Zero gate voltage drain current  | $I_{DSS}$     | $V_{DS} = 40\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_j = 25^\circ\text{C}$          | –   | –    | 1    | $\mu\text{A}$ |
|                                  |               | $V_{DS} = 40\text{ V}$ , $V_{GS} = 0\text{ V}$ ,<br>$T_j = 100^\circ\text{C}^{2)}$ | –   | –    | 4    |               |
| Gate-source leakage current      | $I_{GSS}$     | $V_{GS} = 20\text{ V}$ , $V_{DS} = 0\text{ V}$                                     | –   | –    | 100  | nA            |
| Drain-source on-state resistance | $R_{DS(on)}$  | $V_{GS} = 7\text{ V}$ , $I_D = 15\text{ A}$                                        | –   | 3.53 | 4.16 | m $\Omega$    |
|                                  |               | $V_{GS} = 10\text{ V}$ , $I_D = 30\text{ A}$                                       | –   | 2.81 | 3.25 |               |
| Gate resistance <sup>2)</sup>    | $R_G$         | –                                                                                  | –   | 1.3  | –    | $\Omega$      |

| Parameter                             | Symbol              | Conditions                                                                                       | Values |      |      | Unit |
|---------------------------------------|---------------------|--------------------------------------------------------------------------------------------------|--------|------|------|------|
|                                       |                     |                                                                                                  | min.   | typ. | max. |      |
| Dynamic Characteristics <sup>2)</sup> |                     |                                                                                                  |        |      |      |      |
| Input capacitance                     | C <sub>iss</sub>    | V <sub>GS</sub> = 0 V, V <sub>DS</sub> = 20 V, f = 1 MHz                                         | –      | 1068 | 1388 | pF   |
| Output capacitance                    | C <sub>oss</sub>    |                                                                                                  | –      | 623  | 810  |      |
| Reverse transfer capacitance          | C <sub>rss</sub>    |                                                                                                  | –      | 24   | 36   |      |
| Turn-on delay time                    | t <sub>d(on)</sub>  | V <sub>DD</sub> = 20 V, V <sub>GS</sub> = 10 V,<br>I <sub>D</sub> = 30 A, R <sub>G</sub> = 3.5 Ω | –      | 4    | –    | ns   |
| Rise time                             | t <sub>r</sub>      |                                                                                                  | –      | 4    | –    |      |
| Turn-off delay time                   | t <sub>d(off)</sub> |                                                                                                  | –      | 7    | –    |      |
| Fall time                             | t <sub>f</sub>      |                                                                                                  | –      | 6    | –    |      |

**Gate Charge Characteristics<sup>2)</sup>**

|                       |               |                                                                                  |   |     |     |    |
|-----------------------|---------------|----------------------------------------------------------------------------------|---|-----|-----|----|
| Gate to source charge | $Q_{gs}$      | $V_{DD} = 20\text{ V}, I_D = 30\text{ A},$<br>$V_{GS} = 0\text{ to }10\text{ V}$ | – | 4.6 | 6   | nC |
| Gate to drain charge  | $Q_{gd}$      |                                                                                  | – | 3.3 | 4.9 |    |
| Gate charge total     | $Q_g$         |                                                                                  | – | 16  | 21  |    |
| Gate plateau voltage  | $V_{plateau}$ |                                                                                  | – | 4.3 | –   | V  |

**Reverse Diode**

|                                                |               |                                                                                |   |     |      |    |
|------------------------------------------------|---------------|--------------------------------------------------------------------------------|---|-----|------|----|
| Diode continuous forward current <sup>2)</sup> | $I_S$         | $T_C = 25^\circ\text{C}$                                                       | – | –   | 60   | A  |
| Diode pulse current <sup>2)</sup>              | $I_{S,pulse}$ | $T_C = 25^\circ\text{C}, t_p = 100\ \mu\text{s}$                               | – | –   | 235  |    |
| Diode forward voltage                          | $V_{SD}$      | $V_{GS} = 0\text{ V}, I_F = 30\text{ A}, T_j = 25^\circ\text{C}$               | – | 0.8 | 0.95 | V  |
| Reverse recovery time <sup>2)</sup>            | $t_{rr}$      | $V_R = 20\text{ V}, I_F = 50\text{ A}$<br>$di_F/dt = 100\text{ A}/\mu\text{s}$ | – | 15  | 23   | ns |
| Reverse recovery charge <sup>2)</sup>          | $Q_{rr}$      |                                                                                | – | 3   | 6    | nC |

<sup>1)</sup> Practically the current is limited by the overall system design including the customer-specific PCB.

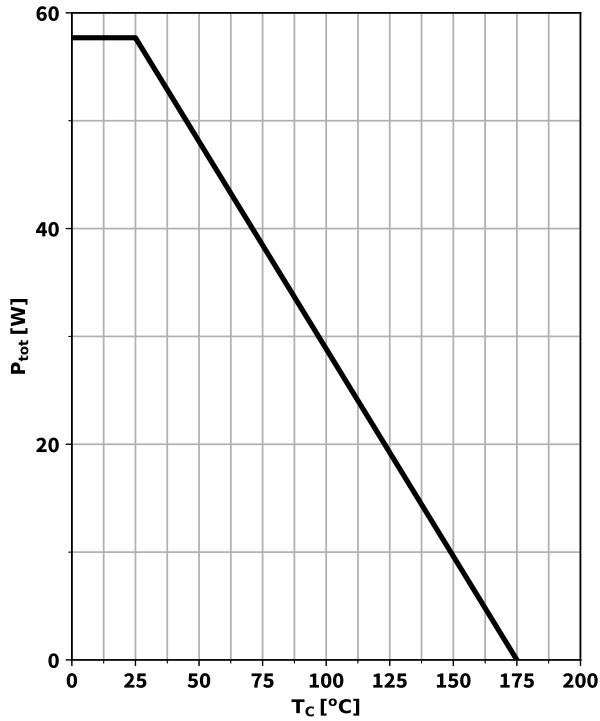
<sup>2)</sup> The parameter is not subject to production testing – specified by design.

<sup>3)</sup> Device on 2s2p FR4 PCB defined in accordance with JEDEC standards (JESD51-5, -7). PCB is vertical in still air.

## Electrical characteristics diagrams

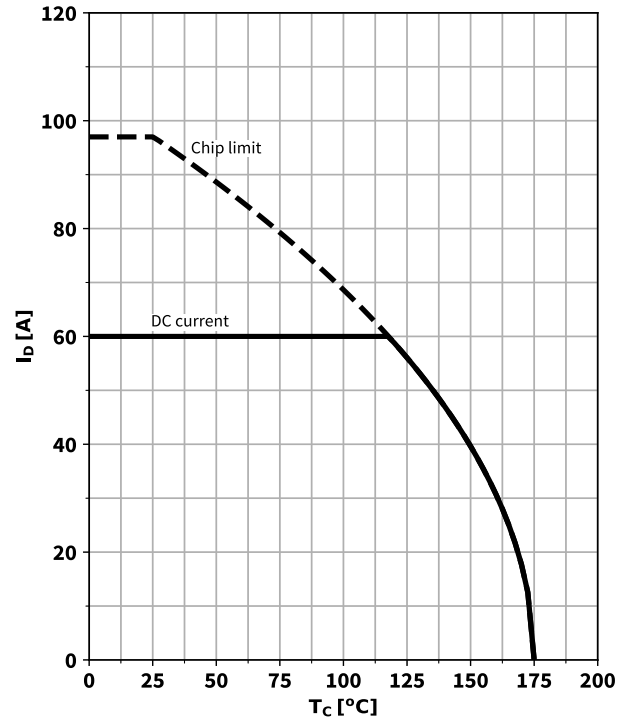
### 1 Power dissipation

$$P_{\text{tot}} = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



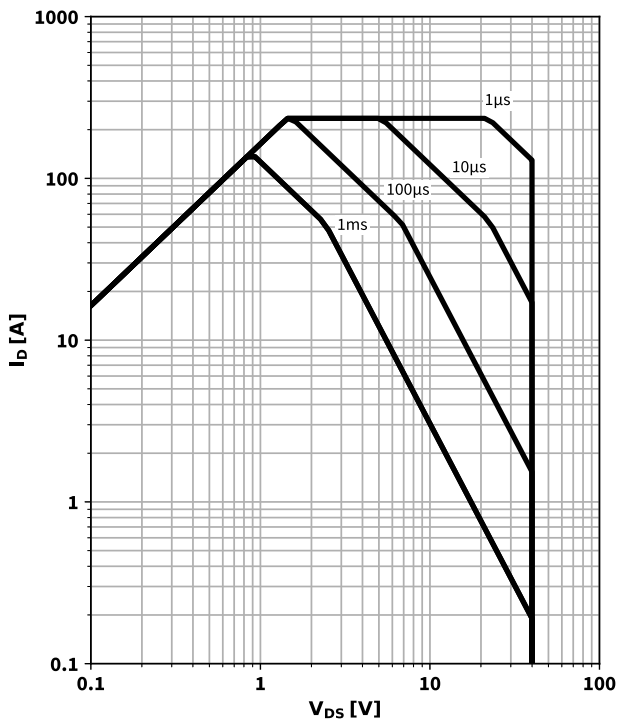
### 2 Drain current

$$I_D = f(T_C); V_{\text{GS}} \geq 6 \text{ V}$$



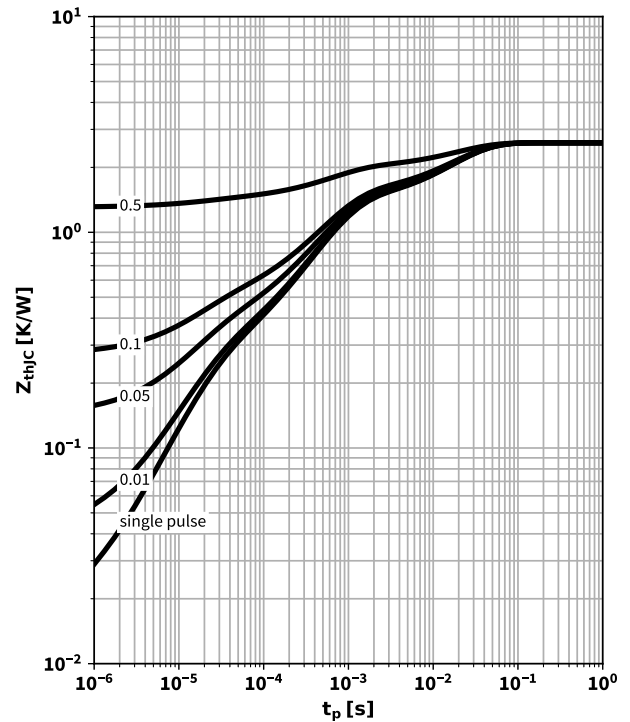
### 3 Safe operating area

$$I_D = f(V_{\text{DS}}); T_C = 25^{\circ}\text{C}; D = 0; \text{parameter: } t_p$$



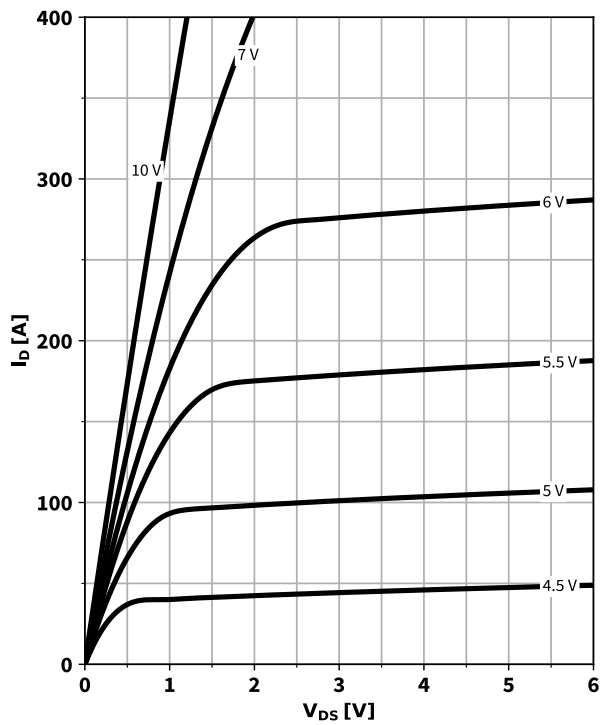
### 4 Max. transient thermal impedance

$$Z_{\text{thJC}} = f(t_p); \text{parameter: } D = t_p/T$$



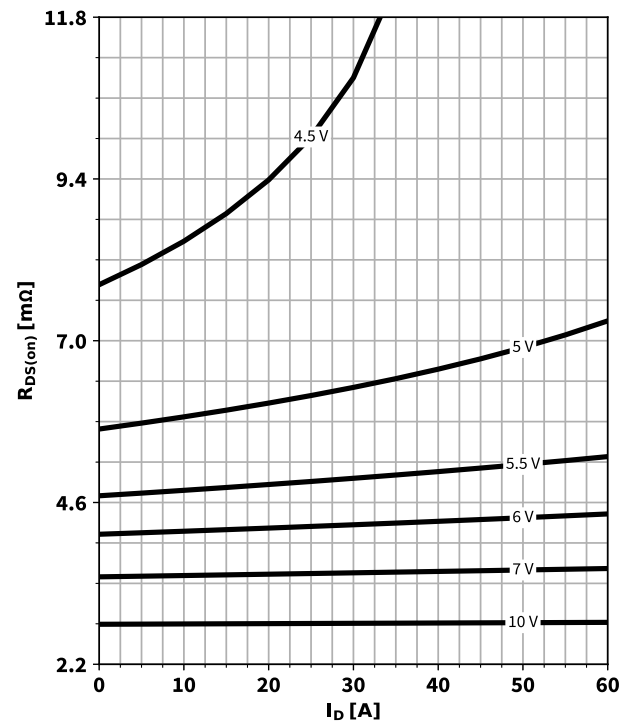
## 5 Typ. output characteristics

$I_D = f(V_{DS}); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$



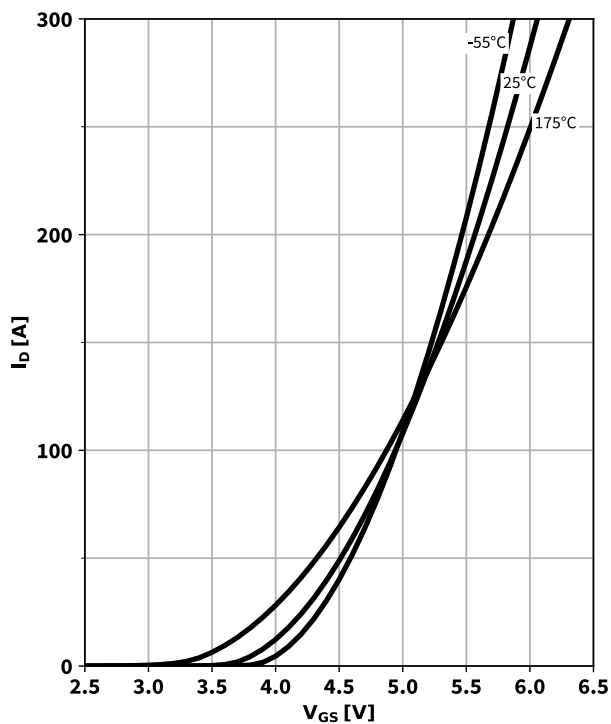
## 6 Typ. drain-source on-state resistance

$R_{DS(on)} = f(I_D); T_j = 25^\circ\text{C}; \text{parameter: } V_{GS}$



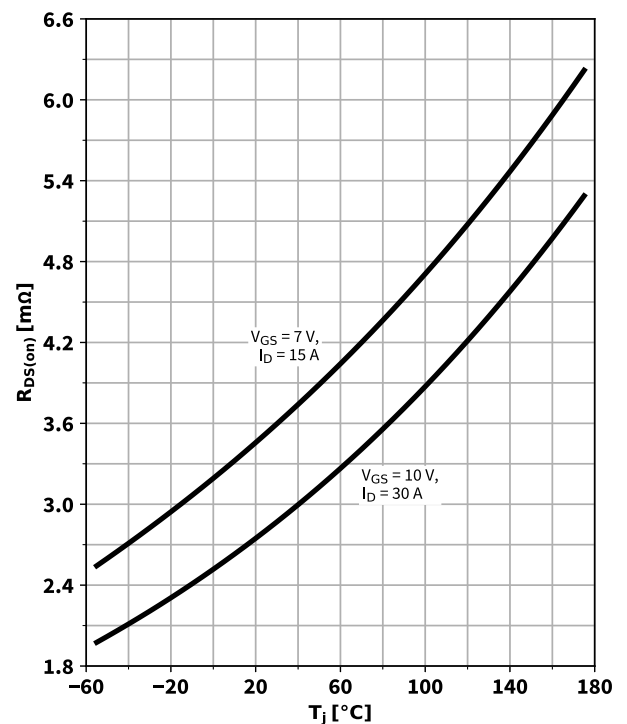
## 7 Typ. transfer characteristics

$I_D = f(V_{GS}); V_{DS} = 6\text{ V}; \text{parameter: } T_j$



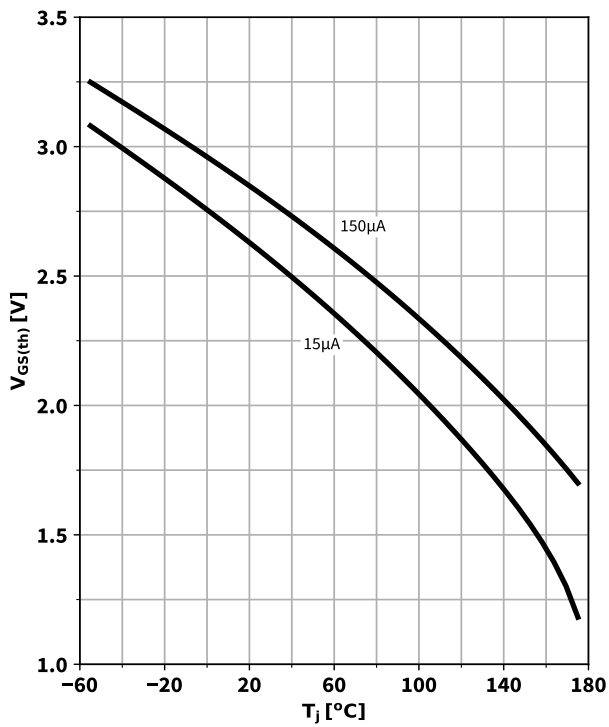
## 8 Typ. drain-source on-state resistance

$R_{DS(on)} = f(T_j); \text{parameter: } I_D, V_{GS}$



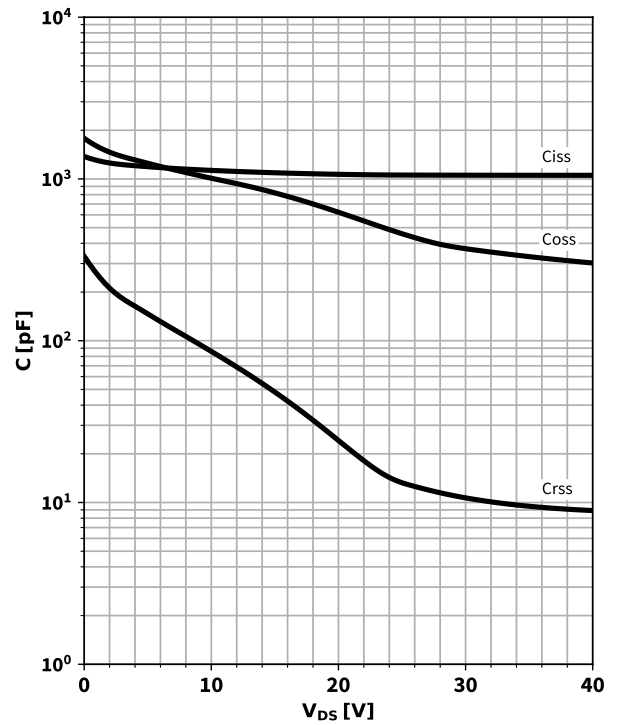
## 9 Typ. gate threshold voltage

$V_{GS(th)} = f(T_j)$ ;  $V_{GS} = V_{DS}$ ; parameter:  $I_D$



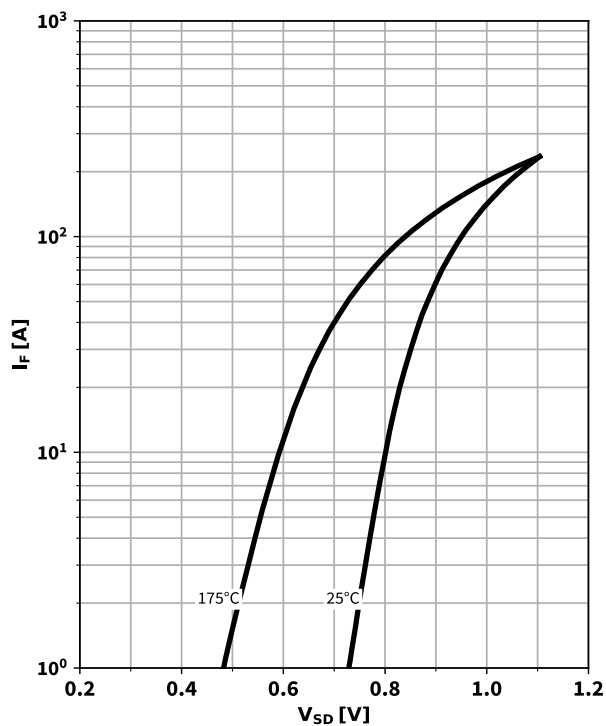
## 10 Typ. capacitances

$C = f(V_{DS})$ ;  $V_{GS} = 0 V$ ;  $f = 1 MHz$



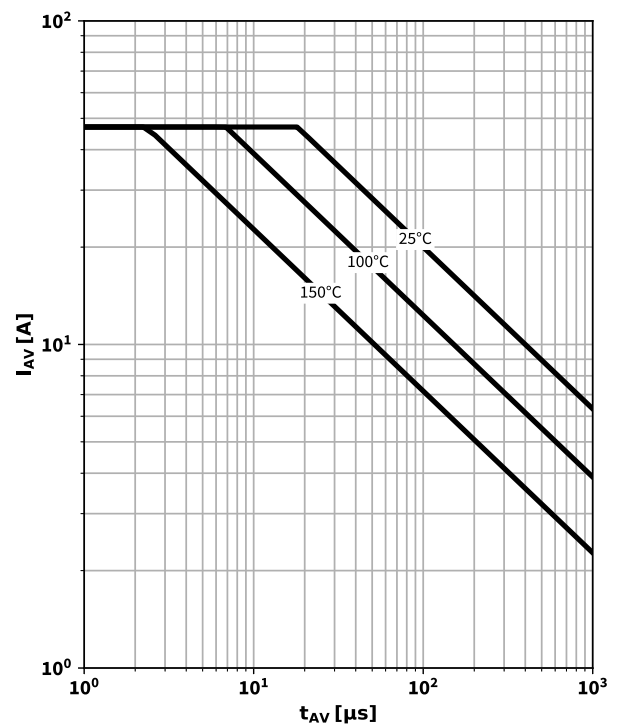
## 11 Typ. forward diode characteristics

$I_F = f(V_{SD})$ ; parameter:  $T_j$



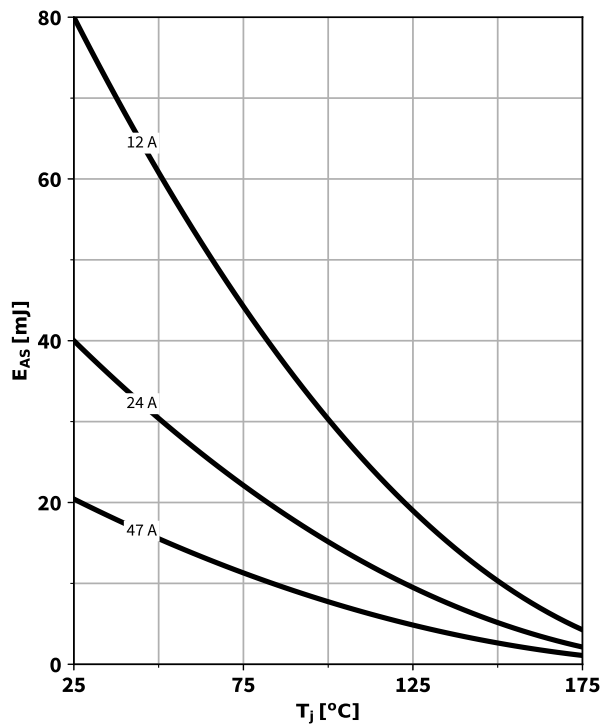
## 12 Typ. avalanche characteristics

$I_{AS} = f(t_{AV})$ ; parameter:  $T_{j(start)}$



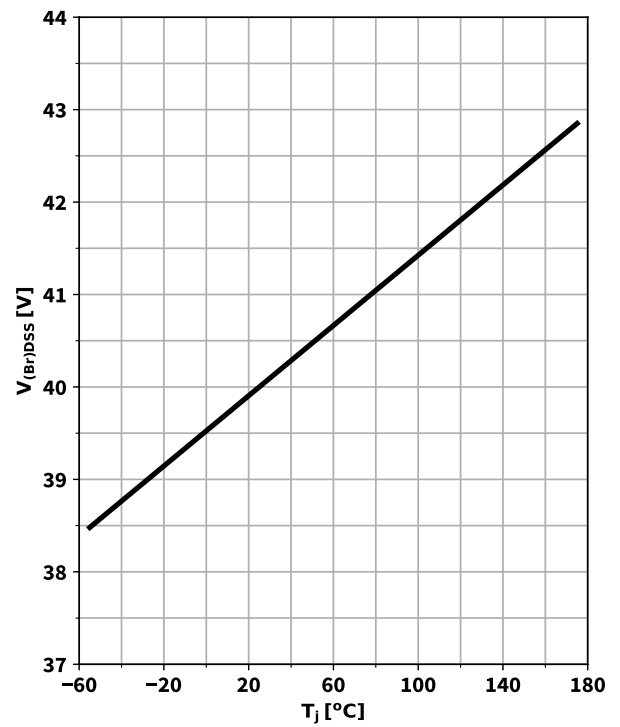
## 13 Typical avalanche energy

$E_{AS} = f(T_j)$ ; parameter:  $I_D$



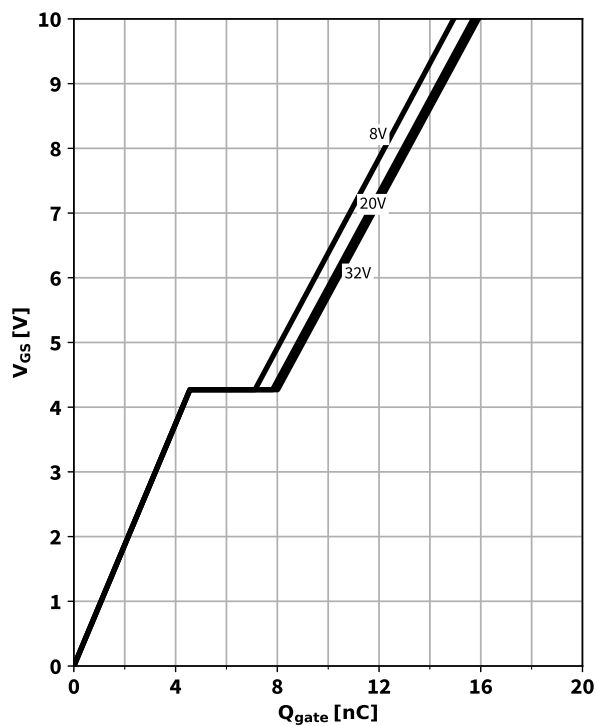
## 14 Drain-source breakdown voltage

$V_{(BR)DSS} = f(T_j)$ ;  $I_D = 1$  mA



## 15 Typ. gate charge

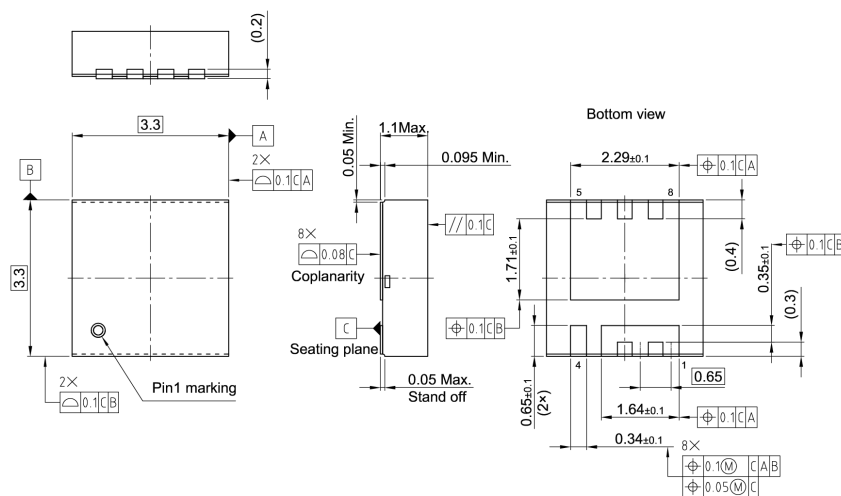
$V_{GS} = f(Q_{gate})$ ;  $I_D = 30$  A pulsed; parameter:  $V_{DD}$



## 16 Gate charge waveforms

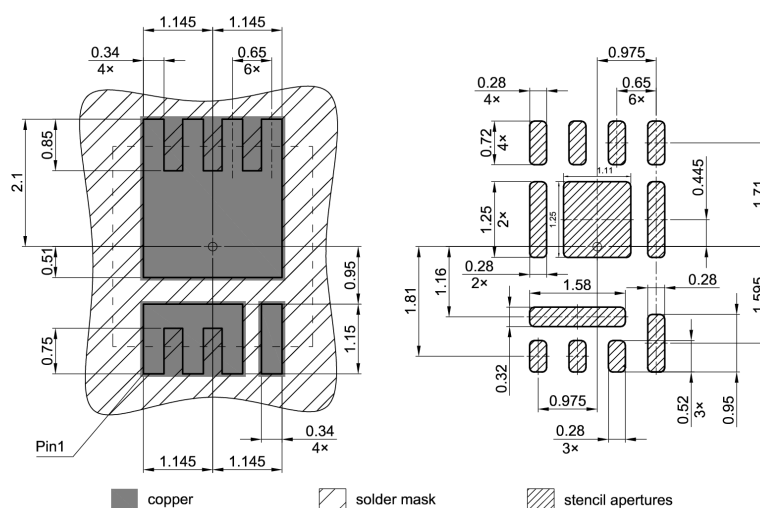


## Package Outline



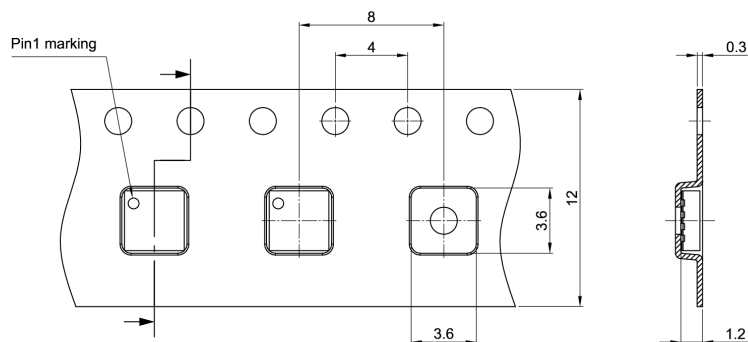
All dimensions are in units mm  
The drawing is in compliance with ISO 128-30, Projection Method 1 [  ]  
Drawing according to ISO 8015, general tolerances ISO 2768-mK

## Footprint



All undimensioned radii are 0.075  
Based on stencil thickness 0.13 mm  
All dimensions are in units mm

## Packaging



All dimensions are in units mm  
The drawing is in compliance with ISO 128-30, Projection Method 1 

## Revision History

| Revision     | Date       | Changes          |
|--------------|------------|------------------|
| Revision 1.0 | 2025-04-08 | Final Data Sheet |

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